# PowerPhase, Dual N-Channel SO8FL

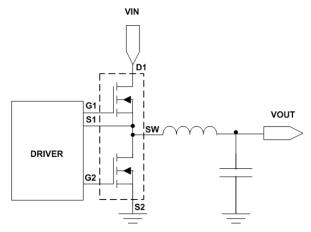
30 V, High Side 20 A / Low Side 24 A

#### **Features**

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- DC-DC Converters
- System Voltage Rails
- Point of Load



**Figure 1. Typical Application Circuit** 

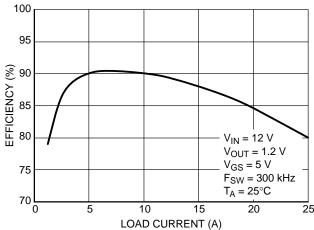


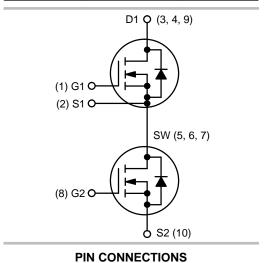
Figure 2. Typical Efficiency Performance POWERPHASEGEVB Evaluation Board



# ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
Q1 Top FET	5.4 mΩ @ 10 V	20.4
30 V	8.1 mΩ @ 4.5 V	20 A
Q2 Bottom	4.4 mΩ @ 10 V	24 A
FET 30 V	6.0 mΩ @ 4.5 V	24 A



# D1 4 5 SW D1 3 9 10 6 SW S1 2 7 SW G1 1 8 G2 (Bottom View)



4C88N = Specific Device Code A = Assembly Location Y = Year

W = Work Week
ZZ = Lot Traceability

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 10 of this data sheet.

**MARKING** 

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter		Symbol	Value	Unit			
Drain-to-Source Voltage	Q1	V <sub>DSS</sub>	30	V			
Drain-to-Source Voltage	Q2						
Gate-to-Source Voltage	Q1	$V_{GS}$	±20	V			
Gate-to-Source Voltage			Q2				
Continuous Drain Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	15.4		
		T <sub>A</sub> = 85°C	1		11.1	1 .	
		T <sub>A</sub> = 25°C	Q2		18.7	A	
		T <sub>A</sub> = 85°C			13.5		
Power Dissipation		T <sub>A</sub> = 25°C	Q1	P <sub>D</sub>	1.89	W	
RθJA (Note 1)			Q2				
Continuous Drain Current $R_{\theta JA} \le 10 \text{ s (Note 1)}$	7	T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	21.0		
		T <sub>A</sub> = 85°C			15.1	A	
	Steady	T <sub>A</sub> = 25°C	Q2		25.4		
	State	T <sub>A</sub> = 85°C			18.3		
Power Dissipation	1	T <sub>A</sub> = 25°C	Q1	$P_{D}$	3.51	W	
$R_{\theta JA} \le 10 \text{ s (Note 1)}$			Q2				
Continuous Drain Current	1	T <sub>A</sub> = 25°C	Q1	I <sub>D</sub>	11.7		
R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 85°C			8.5		
		T <sub>A</sub> = 25°C	Q2		14.2	A	
		T <sub>A</sub> = 85°C			10.3	1	
Power Dissipation	7	T <sub>A</sub> = 25 °C	Q1	P <sub>D</sub>	1.10	W	
R <sub>θJA</sub> (Note 2)			Q2				
Pulsed Drain Current		T <sub>A</sub> = 25°C	Q1	I <sub>DM</sub>	160	А	
		t <sub>p</sub> = 10 μs	Q2		240		
Operating Junction and Storage Temperature			Q1	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
	Q2						
Source Current (Body Diode)	Q1	I <sub>S</sub>	10	А			
	Q2		10				
Drain to Source DV/DT		dV/dt	6	V/ns			
Single Pulse Drain-to-Source Avalanche Energy (T	Q1	EAS	20	mJ			
$V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	Q2	EAS	29				
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	I <sub>L</sub> = 24 A <sub>pk</sub>		TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 sq—in pad, 2 oz Cu.

2. Surface—mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	66.0	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	113.7	°C/W
Junction-to-Ambient - (t ≤ 10 s) (Note 3)	$R_{\theta JA}$	35.6	

- Surface–mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
   Surface–mounted on FR4 board using the minimum recommended pad size of 100 mm<sup>2</sup>.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Symbol Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS						•		<u> </u>
Drain-to-Source Break-	Q1	.,	., .,,		30			V
down Voltage	Q2	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V$ ,	I <sub>D</sub> = 250 μA	30			
Drain-to-Source Break-	Q1	V <sub>(BR)</sub> DSS				18		mV /
down Voltage Temperature Coefficient	Q2	/T <sub>J</sub>				17		°C
	Q1		$V_{GS} = 0 V$	T <sub>J</sub> = 25°C			1	
Zero Gate Voltage Drain		I <sub>DSS</sub>	$V_{DS} = 24 \text{ V}$	T <sub>J</sub> = 125°C			10	μΑ
Current	Q2	1000	$V_{GS} = 0 V$ , $V_{DS} = 24 V$	T <sub>J</sub> = 25°C			1	
Gate-to-Source Leakage	Q1		V <sub>GS</sub>	= 0 V,			100	A
Current		I <sub>GSS</sub>	$V_{DS} = \pm 20 \text{ V}$				100	nA
ON CHARACTERISTICS (Note	e 5)							
Gate Threshold Voltage	Q1	V	$V_{GS} = VDS$ ,		1.3		2.2	V
	Q2	$V_{GS(TH)}$ $I_D = 250 \mu a$		250 μA	1.3		2.2	v
Negative Threshold Temper-	Q1	V <sub>GS(TH)</sub> /				4.5		mV /
ature Coefficient	Q2	ŤJ				4.6		°C
	Q1	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}$	I <sub>D</sub> = 10 A		4.3	5.4	
Drain-to-Source On Resist-			$V_{GS} = 4.5 \text{ V}$	I <sub>D</sub> = 10 A		6.5	8.1	mΩ
ance	Q2		$V_{GS} = 10 \text{ V}$	I <sub>D</sub> = 20 A		2.8	4.4	11152
			$V_{GS} = 4.5 \text{ V}$ $I_D = 20 \text{ A}$			4.0	6.0	
CAPACITANCES								
Input Capacitance	Q1				1252			
Input Capacitance		C <sub>ISS</sub>				1546		
Output Capacitance	Q1	Coop		MHz Vpa = 15 V		610		pF
Output Capacitance Q2 Coss V <sub>GS</sub> =		vGS - 0 v, i = 1	0 V, f = 1 MHz, V <sub>DS</sub> = 15 V		841			
Reverse Capacitance	Q1	C <sub>RSS</sub>				126		
Noverse Capacitance	Q2	CRSS				39		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition		Min	Тур	Max	Unit
CHARGES, CAPACITANCE	& GATE	RESISTANC	E				•	
T. 10 1 01	Q1					10.9		
Total Gate Charge	Q2	$Q_{G(TOT)}$				11		
TI 1 110 1 01	Q1	_				1.2		
Threshold Gate Charge	Q2	Q <sub>G(TH)</sub>	V 45V/V	45.77.1 40.4		1.6		
0-1-1-0	Q1	_	$V_{GS} = 4.5 \text{ V}, V_{DS}$	= 15 V; I <sub>D</sub> = 10 A		3.4		nC
Gate-to-Source Charge	Q2	$Q_GS$				4.4		
Onto the Duning Observe	Q1	0				5.4		
Gate-to-Drain Charge	Q2	$Q_GD$				2.9		
T. 10 . 0	Q1		.,	45.77.1 40.4		22.2		_
Total Gate Charge	Q2	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS}$	= 15 V; I <sub>D</sub> = 10 A		24.2		nC
0	Q1	$R_{G}$	_			1.0		
Gate Resistance	Q2		ΙΑ =	25°C		1.0		Ω
SWITCHING CHARACTERIS	STICS (No	te 6)					•	
T 0 D   T	Q1					9.4		
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				10.7		- - ns
	Q1					19		
Rise Time	Q2	t <sub>r</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			4.8		
T 0" D   T	Q1	,				16		
Turn-Off Delay Time	Q2	<sup>t</sup> d(OFF)				19.3		
E-U.T.	Q1					4.6		
Fall Time	Q2	t <sub>f</sub>				4.7		
SWITCHING CHARACTERIS	STICS (No	te 6)						
Turn On Dolov Time	Q1					6.8		
Turn-On Delay Time	Q2	t <sub>d(ON)</sub>				7.5		
Diag Time	Q1	t <sub>r</sub>				17		
Rise Time	Q2		V <sub>GS</sub> = 10 V,	V <sub>DS</sub> = 15 V,		2.7		
Town Off Dalay Trees	Q1		$I_{D} = 15 \text{ A},$	$I_D = 15 \text{ A}, R_G = 3.0 \Omega$		20.6		ns
Turn-Off Delay Time	Q2	t <sub>d(OFF)</sub>				24.8		
	Q1					2.64		
Fall Time	Q2	t <sub>f</sub>				2.88		
DRAIN-SOURCE DIODE CH	IARACTE	RISTICS						
	04		$V_{GS} = 0 V$	$T_J = 25^{\circ}C$		0.82		
Famous and Malks	Q1	.,	$V_{GS} = 0 V$ , $I_S = 10 A$	T <sub>J</sub> = 125°C		0.64		
Forward Voltage	6.5	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8		V
	Q2		$I_{S} = 10 \text{ A}$	T <sub>J</sub> = 125°C		0.62		1

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

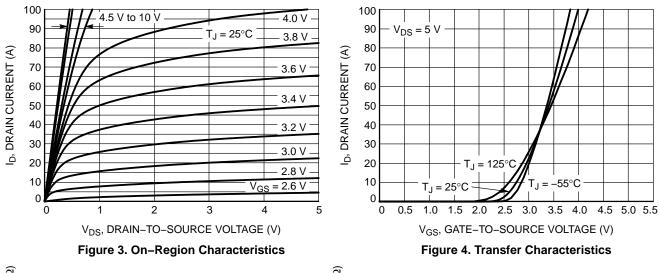
Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	FET	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHA	RACTE	RISTICS					
Povorco Pocovory Timo	Q1	4			29		
Reverse Recovery Time	Q2	t <sub>RR</sub>			16.7		
Chargo Timo	Q1	to			14.2		ns
Charge Time	Q2	ta			19.5		
Discharge Time	Q1	4h	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A/}\mu\text{s}, I_S = 10 \text{ A}$		15.0		
Discharge Time	Q2	tb			36.2		1
Dayaraa Dagayary Charga	Q1					18.1	
Reverse Recovery Charge	Q2	$Q_{RR}$			27.4		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ . 6. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS - Q1**



DRAIN-TO-SOURCE RESISTANCE (₺) DRAIN-TO-SOURCE RESISTANCE (₺) 0.026 0.009 0.024 0.022  $I_{D} = 20 \text{ A}$ 0.008  $T_J = 25^{\circ}C$ 0.020 V<sub>GS</sub> = 4.5 V 0.018 0.007 0.016 0.014 0.006 0.012 0.005 0.010 V<sub>GS</sub> = 10 V 0.008 0.006 0.004 R<sub>DS(on)</sub>, I R<sub>DS(on)</sub>, I 0.004 0.003 0.002 7 20 30 40 50 6 8 9 10 10 60 70 4 5 V<sub>GS</sub>, GATE VOLTAGE (V) ID, DRAIN CURRENT (A)

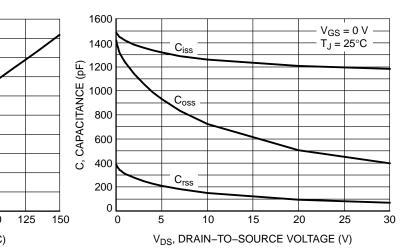
Figure 5. On-Resistance vs. Gate-to-Source Voltage

1.7

V<sub>GS</sub> = 10 V

 $I_{D} = 20 \text{ A}$ 

0.7



-25 25 50 75 100 -50 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 7. On-Resistance Variation with **Temperature** 

Figure 8. Capacitance Variation

Figure 6. On-Resistance vs. Drain Current and **Gate Voltage** 

#### **TYPICAL CHARACTERISTICS - Q1**

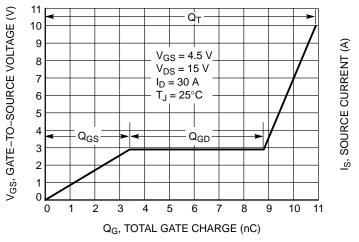


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

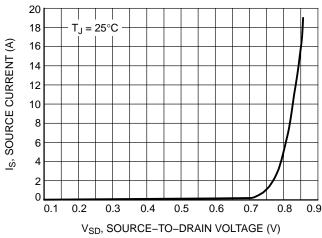


Figure 10. Diode Forward Voltage vs. Current

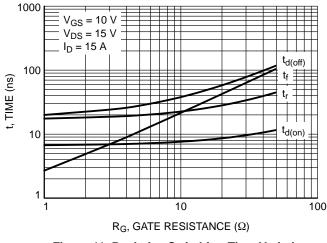


Figure 11. Resistive Switching Time Variation vs. Gate Resistance

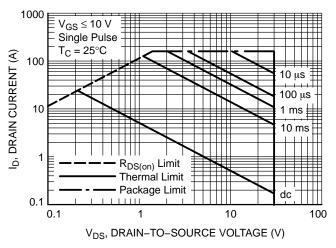


Figure 12. Maximum Rated Forward Biased Safe Operating Area

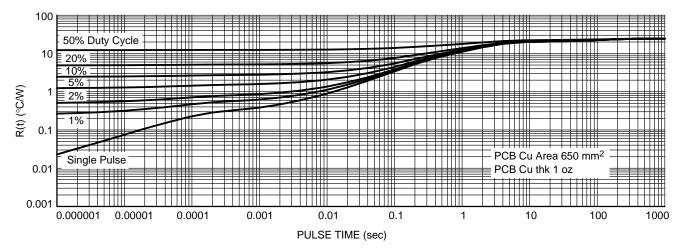


Figure 13. Thermal Characteristics

#### **TYPICAL CHARACTERISTICS - Q2**

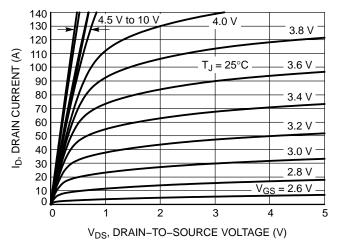


Figure 14. On-Region Characteristics

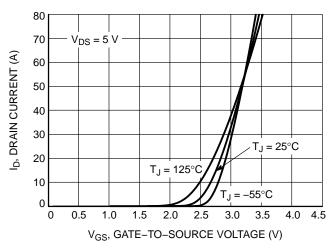


Figure 15. Transfer Characteristics

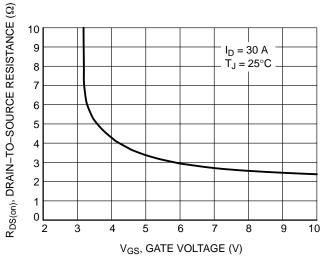


Figure 16. On-Resistance vs. Gate-to-Source Voltage

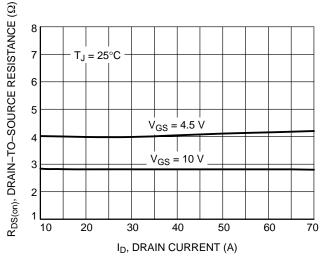


Figure 17. On-Resistance vs. Drain Current and Gate Voltage

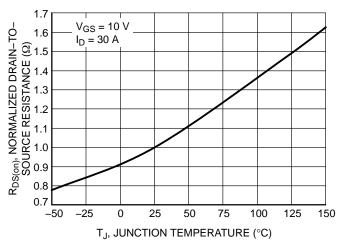


Figure 18. On–Resistance Variation with Temperature

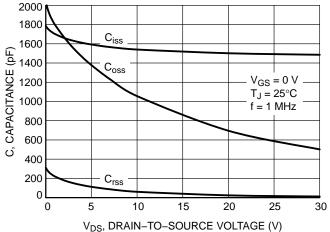


Figure 19. Capacitance Variation

#### **TYPICAL CHARACTERISTICS - Q2**

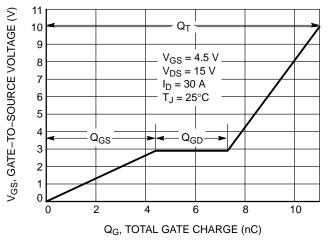


Figure 20. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

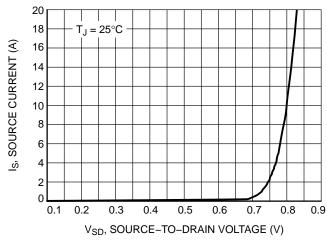


Figure 21. Diode Forward Voltage vs. Current

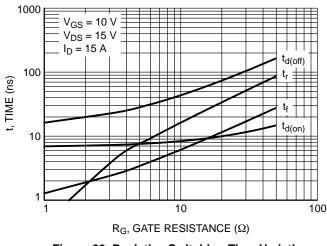


Figure 22. Resistive Switching Time Variation vs. Gate Resistance

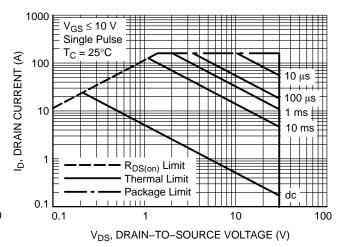


Figure 23. Maximum Rated Forward Biased Safe Operating Area

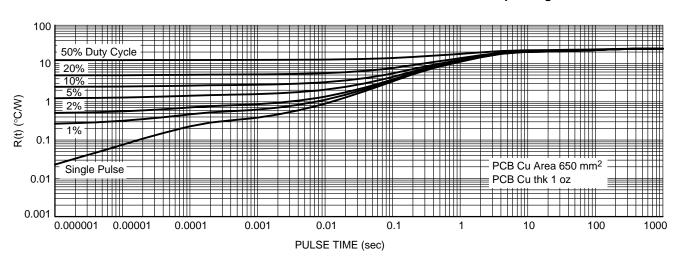


Figure 24. Thermal Characteristics

#### **ORDERING INFORMATION**

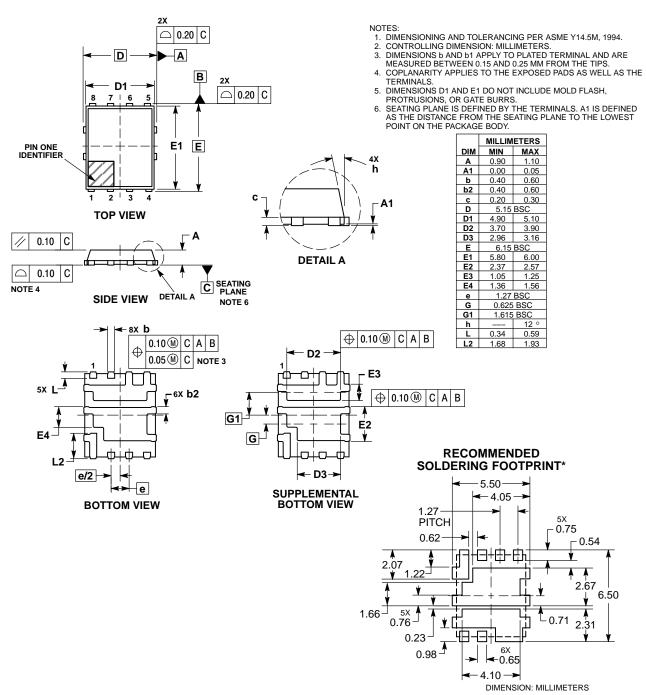
Device	Package	Shipping <sup>†</sup>
NTMFD4C88NT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NTMFD4C88NT3G	DFN8 (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# DFN8 5x6, 1.27P PowerPhase FET CASE 506CR

ISSUE B



<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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